

SPECIFICATION FOR LCM MODULE

MODULE NO.:TFT-0162 DOC. REVISION01

Customer Approval:

	SIGNATURE	DATE
PREPARED BY (RD ENGINEER)		
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APPROVED BY		

WRITTEN BY	CHECKED BY	APPROVED BY

Notes:

1. Please contact GTK before assigning your product based on this module specification.

2. To improve the quality of product, and this product specification is subject to change without any notice.

REVISION RECORD

REV NO.	REV DATE	CONTENTS	REMARKS
V0.1	2014-12-25	First release	Preliminary

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■ GENERAL INFORMATION

Item of general information	Contents	Unit	
LCD size	12.1 inch	/	
LCD type	TFT/TRANSMISSIVE normal white		
View direction	12 o'clock		
Resolution	800*3(RGB)*600		
Module size ($W \times H \times T$)	279(W)×209(H)×9.0(T)	mm ³	
Active area (W×H)	246(W)×184.5(H)	mm ²	
Pixel pitch ($W \times H$)	0.3075(W)×0.3075(H)	mm ²	
Interface Type	LVDS interface	/	
Input voltage	3.3V	V	
Module Power consumption	6.7(Frame rate=60HZ)	W	
Backlight Type	LED /		

■ ABSOLUTE MAXIMUM RATINGS

Item	Symbol	MAX	Unit
Supply voltage	VDD	3.6	V
CMOS/TTL input voltage	Vin	3.6	V
CMOS/TTL input voltage	Vout	3.6	V
LVDS receiver input voltage	Vin	3.6	V
Operating temperature range	TOPR	-40~95	°C
Storage Temperature range	TSTG	-55~125	°C

■ ELECTRICAL CHARACTERISTICS DC CHARACTERISTICS

Parameter	Symbol	Conditions		Spec.		Unit
			Min.	Тур.	Max.	
Supply voltage	VDD	-	-	3.3	-	V
Supply Current	ldd	F=54MHz VDD33=3.3V PI=13KΩ,RL=100Ω Pixel checker pattern	-	75	_	mA
	CM	IOS/TTL DC SPECIFIC	ATIONS			
High Level Input Voltage	Vih	-	0.7VDD33	-	VDD33	V
Low Level Input Voltage	Vil	-	VSS	-	0.3VDD33	V
High Level Output Voltage	Voh	-	0.8VDD33	-	VDD33	V
Low Level Output Voltage	Vol	-	VSS	-	0.2VDD 33	V

Product Name:TFT-0162

		LVDS DC SPECIFICA	TIONS			
Differential Input High	Vth		-			mV
Threshold				-	+100	
Differential Input Low	Vtl		-100	-		mV
Threshold		Vlvcm=1.2V			-	
LVDS Common mode	Vic	-	0.7	-	1.6	V
LVDS swing Voltage	Vid	-	±100	-	±600	mV
Input Current	lin	Vin=+2.4V/0V	-	-	10	μA
		RSDS DC SPECIFICA	TIONS			
Output differential voltage	Vod	RL=100Ω	-	TBD	-	mV
	Vos	PI=13KΩ	1.0	1.2		V
Output offset voltage		(Temp=25℃)			1.4	
	los	Output shorted to	-	-3.5		mA
Output Current		GND			-5.0	

■ BACKLIGHT CHARACTERISTICS

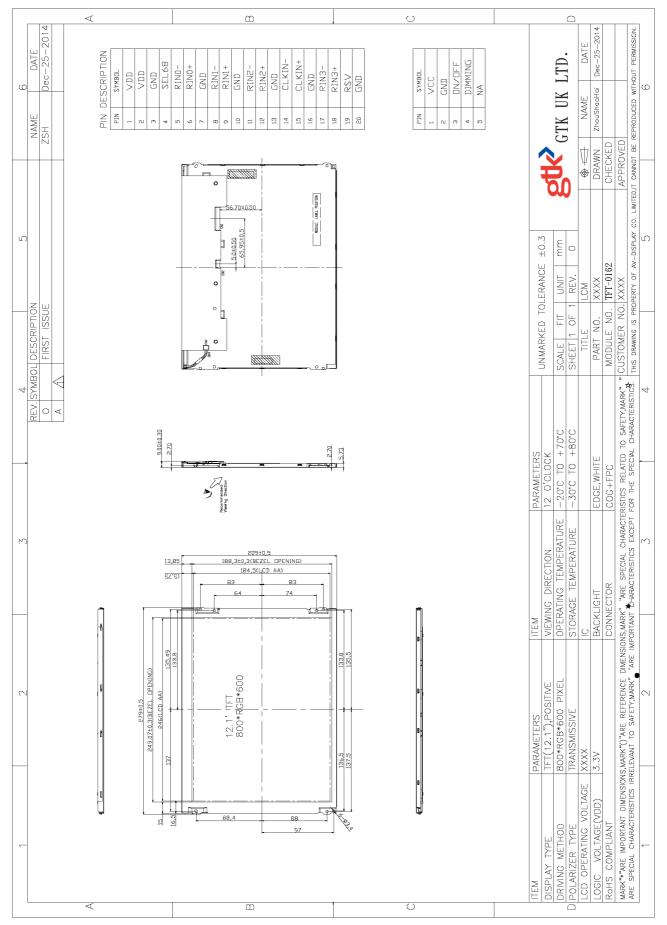
Parameter	Symbol	Min	Тур	Max	Unit	Remark
LED Forward Voltage	VF	25.2	27.9	31.5	V	-
LED Forward Current	IF		160		mA	_
LED Power Consumption	PLED	4.03	4.47	5.04	W	Note 1
LED Life-Time	N/A	50,000			Hrs	IF = 80mA Note 2

Notes:

1. Calculator Value for reference IF \times VF \times LED Quantity = PLED

2. The LED Life-time define as the estimated time to 50% degradation of initial luminous.

EXTERNAL DIMENSIONS



■ ELECTRO-OPTICAL CHARACTERISTICS

Item of electro-optical characteristics	Symbol	Condition	Min	Тур	Max	Unit	Remark	Note
Response time	Tr+ Tf		—	30	_	ms	Fig.1	4
Contrast ratio	Cr		600	800	_		FIG 2.	1
Luminance uniformity	δ WHITE		75	80	_	%	FIG 2.	3
Surface Luminance	Lv		330	450	_	cd/m ²	FIG 2.	2
		$\emptyset = 90^{\circ}$	55	65	_	deg	FIG 3.	
Viewing angle		$\emptyset = 270^{\circ}$	65	75	_	deg	FIG 3.	6
range	θ	$\emptyset = 0^{\circ}$	70	80	_	deg	FIG 3.	0
		$\emptyset = 180^{\circ}$	70	80	_	deg	FIG 3.	
	Red x			TBD		-		
	Red y			TBD		-		
	Green x	$\theta = 0^{\circ}$		TBD		-		
CIE (x, y)		$\emptyset = 0^{\circ}$		TBD		-	FIG 2.	5
chromaticity		$Ta=25^{\circ}C$		TBD		-		
		1 a-23 C		TBD		-		
	White x			TBD		-		
	White y			TBD		-		

Note1. Contrast Ratio(CR) is defined mathematically by the following formula. For more information see FIG 2.: Contrast Ratio = $\frac{\text{Average Surface Luminance with all white pixels (P1, P2, P3, P4, P5)}{2}$

Average Surface Luminance with all black pixels (P1, P2, P3, P4, P5)

Note2. Surface luminance is the LCD surface from the surface with all pixels displaying white. For more information see FIG 2.

Lv = Average Surface Luminance with all white pixels (P1, P2, P3, P4, P5)

Note3. The uniformity in surface luminance (δ WHITE) is determined by measuring luminance at each test position 1 through 5, and then dividing the maximum luminance of 5 points luminance by minimum luminance of 5 points luminance. For more information see FIG 2.

 δ WHITE = <u>Minimum Surface Luminance with all white pixels (P1, P2, P3, P4, P5)</u>

Maximum Surface Luminance with all white pixels (P1, P2, P3, P4, P5)

- Note4. Response time is the time required for the display to transition from White to black(Rise Time, Tr) and from black to white(Decay Time, Tf). For additional information see FIG 1..
- Note5. CIE (x, y) chromaticity ,The x,y value is determined by screen active area position NO.5 For more information see FIG 2.
- Note6. Viewing angle is the angle at which the contrast ratio is greater than 2. For TFT module the conrast ratio is greater than 10. The angles are determined for the horizontal or x axis and the vertical or y axis with respect to the z axis which is normal to the LCD surface. For more information see FIG 3.
- Note7. For Viewing angle and response time testing, the testing data is base on Autronic-Melchers's ConoScope. Series Instruments. For contrast ratio, Surface Luminance, Luminance uniformity and CIE, the testing data is base on TOPCON's BM-5 photo detector or compatible.

Note8. For TFT module, Gray scale reverse occurs in the direction of panel viewing angle



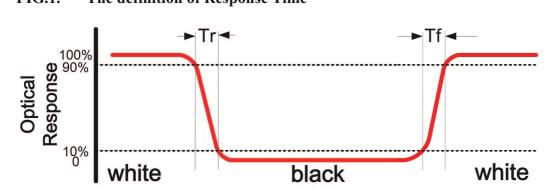


FIG.2. Measuring method for Contrast ratio, surface luminance, Luminance uniformity, CIE (x, y) chromaticity

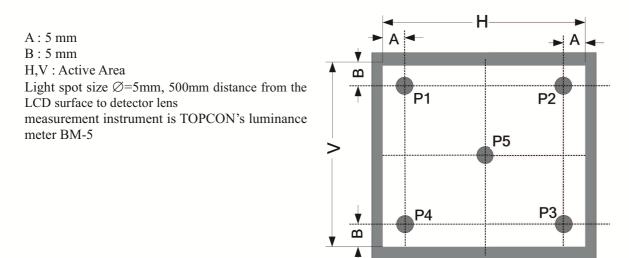
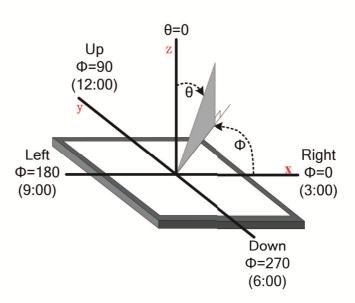


FIG.3. The definition of viewing angle



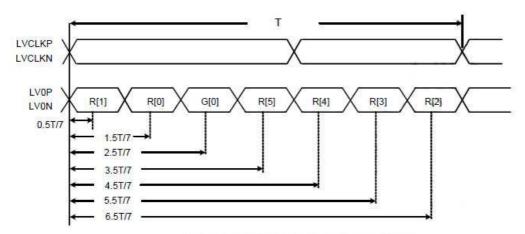
Interface NO.	ACE DESCRI	I/O or connect to	DESCRIPTION
1-2	VDD	Р	Power Supply, 3.3V (typical)
3	GND	Р	Ground
4	SEL68	Ι	LVDS 6/8 bit select function control, Low or NC 6 bit Input Mode High 8bit Input Mode
5	RIN0-	Ι	- LVDS differential data input (R0-R5,G0)
6	RIN0+	Ι	+LVDS differential data input (R0-R5,G0)
7	GND	Р	Ground
8	RIN1-	Ι	- LVDS differential data input(G1-G5,B0-B1)
9	RIN1+	Ι	+LVDS differential data input (G1-G5,B0-B1)
10	GND	Р	Ground
11	RIN2-	Ι	- LVDS differential data input (B2-B5,HS,VS,DE)
12	RIN2+	Ι	+LVDS differential data input (B2-B5,HS,VS,DE)
13	GND	Р	Ground
14	CIKIN-	Ι	-LVDS differential clock input
15	CIKIN+	Ι	+LVDS differential clock input
16	GND	Р	Ground
17	RIN3-	Ι	- LVDS differential data input (R6-R7,G6-G7, B6-B7,RSV)
18	RIN3+	Ι	+LVDS differential data input (R6-R7,G6-G7, B6-B7,RSV)
19	RSV	/	Reverse scan founction(H:enanble,L/NC:disable)
20	GND	Р	Ground

Backlight interface

Interface NO.	symbol	DESCRIPTION
1	VCC	12V input
2	GND	GND
3	ON/OFF	5V-ON,0V-OFF
4	Dimming	PWM
5	NA	

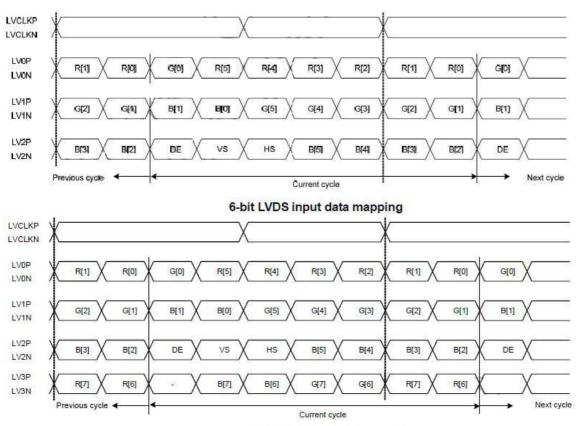
Remark: PWM frequency 120~1Khz

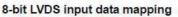
AC CHARACTERISTICS Signal timing specification Ideal strobe position for LVDS input



LVDS input data ideal strobe position

LVDS input data mapping





Input timing

DE mode

Parameter	Symbol	Condition	SVGA 800X600	Unit
DCLK frequency	FDCLK	Тур.	40	MHz
Horizontal total		Min.	900	TDCLK
timing	T _H	Тур.	1056	TDCLK
uning		Max.	2047	TDCLK
Horizontal active timing	T _{ha}	Тур.	800	TDCLK
		Min.	604	Тн
Vertical total	T _V	Typ.	630	T _H
timing		Max.	1023	T _H
Vertical active timing	T _{VA}	Тур.	600	T _H

SYNC mode

Parameter	Symbol	SVGA 800X600	Unit
DCLK frequency	FDCLK	40	MHz
Horizontal total timing	T _H	1056	TDCLK
HD pulse width	TWHL	3	TDCLK
HD back porch	T _{HBP}	216	TDCLK
HD front porch	T _{HFP}	37	TDCLK
Horizontal active timing	T _{HA}	800	TDCLK
Vertical total timing	T _V	630	T _H
VD pulse width	TWVL	1	T _H
VD back porch	T _{VBP}	27	T _H
VD front porch	TVFP	2	T _H
Vertical active timing	TVA	600	T _H

■ POWER SEQUENCE Power up sequence VHYS + VTH VDD33 OV RESETB T_{RST} T_{RST} H ł Figure 0.3: Power up sequence Spec. Typ. Max. Symbol Condition Unit Parameter Min. V_{TH} V_{HYS} T_{RST} Reset threshold voltage Hysteresis voltage Reset duration @R=10KΩ, C=1µF 2.1 200 2 2.2 V

mV

ms

-

+ 10

■ REFERENCE APPLICATION CIRCUIT

Please consult our technical department for detail information.

■ RELIABILITY TEST CONDITIONS

No.	Test Item	Test Condition	Inspection after test
1	High Temperature Storage	$80\pm2^{\circ}C/240$ hours	
2	Low Temperature Storage	$-30\pm2^{\circ}C/240$ hours	
3	High Temperature Operating	$70\pm2^{\circ}C/120$ hours	
4	Low Temperature Operating	$-20\pm2^{\circ}C/120$ hours	Inspection after 2~4hours storage at
5	Temperature Cycle	$\begin{array}{c} -20 \pm 2^{\circ} \mathbb{C} \sim 25 \sim 70 \pm 2^{\circ} \mathbb{C} \times 10 \text{ cycles} \\ (30 \text{min.}) (5 \text{min.}) (30 \text{min.}) \end{array}$	room temperature, the sample shall be free from
6	Damp Proof Test	$50^{\circ}\text{C} \pm 5^{\circ}\text{C} \times 90\%$ RH/120 hours	defects:
7	Vibration Test	Frequency: 10Hz~55Hz~10Hz Amplitude: 1.5mm, X, Y, Z direction for total 3hours (Packing condition)	 Air bubble in the LCD; Sealleak; Non-display; missing segments;
8	Dropping test	Drop to the ground from 1m height, one time, every side of carton. (Packing condition)	5.Glass crack;6.Current Idd is twice higher than initial value.
9	ESD test	Voltage:±8KV R: 330Ω C: 150pF Air discharge, 10time	

Remark:

1. The test samples should be applied to only one test item.

2.Sample size for each test item is $5 \sim 10$ pcs.

3.For Damp Proof Test, Pure water(Resistance>10M Ω) should be used.

4.In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judged as a good part.

5.EL evaluation should be excepted from reliability test with humidity and temperature: Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence EL has.

6.Failure Judgment Criterion: Basic Specification, Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.

■ INSPECTION CRITERION

This specification is made to be used as the standard acceptance/rejection criteria for Normal LCM Product.

1 Sample plan

Sampling plan according to GB/T2828.1-2003/ISO 2859-1: 1999 and ANSI/ASQC Z1.4-1993, normal level 2 and based on:

Major defect: AQL 0.65

Minor defect: AQL 1.5

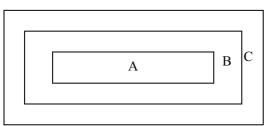
2. Inspection condition

• Viewing distance for cosmetic inspection is about 30cm with bare eyes, and under an environment of $20\sim40W$ light intensity, all directions for inspecting the sample should be within 45° against perpendicular line. (Normal temperature $20\sim25^{\circ}$ C and normal humidity $60\pm15\%$ RH).

• Driving voltage

The Vop value from which the most optimal contrast can be obtained near the specified Vop in the specification (Within ± 0.5 V of the typical value at 25°C.).

3. Definition of inspection zone in LCD.



Zone A: character/Digit area

Zone B: viewing area except Zone A (ZoneA+ZoneB=minimum Viewing area)

Zone C: Outside viewing area (invisible area after assembly in customer's product)

Fig.1 Inspection zones in an LCD.

Note: As a general rule, visual defects in Zone C are permissible, when it is no trouble for quality and assembly of customer's product.

4.Inspection Standard

4.1 Major Defect

Item No	Items to be inspected	Inspection Standard	Classification of defects
4.1.1	All functional defects	 No display Display abnormally Missing vertical, horizontal segment Short circuit Back-light no lighting, flickering and abnormal lighting. 	
4.1.2	Missing	Missing component	Major
4.1.3	Outline dimension	Overall outline dimension beyond the drawing is not allowed.	

4.2 Cosmetic Defect

4.2.1 Module Cosmetic Criteria

No.	Item	Judgement Criterion	Partition
1	Difference in Spec.	None allowed	Major
2	Pattern peeling	No substrate pattern peeling and floating	Major
3	Soldering defects	No soldering missing	Major
		No soldering bridge	Major
		No cold soldering	Minor
4	Resist flaw on Printed Circuit Boards	visible copper foil (\emptyset 0.5mm or more) on substrate pattern	Minor
5	Accretion of metallic	No accretion of metallic foreign matters (Not exceed \emptyset 0.2mm)	Minor
	Foreign matter		Minor
6	Stain	No stain to spoil cosmetic badly	Minor
7	Plate discoloring	No plate fading, rusting and discoloring	Minor
8	Solder amount	a. Soldering side of PCB	Minor
	1. Lead parts	Solder to form a 'Filet' all around the lead. Solder should not hide the lead form perfectly. (too much) b. Components side (In case of 'Through Hole PCB') Solder to reach the Components side of PCB.	
	2. Flat packages	Either 'Toe' (A) or 'Seal' (B) of the lead to be covered by 'Filet'.	Minor
	3. Chips	$(3/2) H \ge h \ge (1/2) H$	Minor

9	Solder ball/Solde		Minor
	splash	the conductor or solder pad $h \ge 0.13 \text{mm}$ The diameter of solder ball $d \le 0.15 \text{mm}$. b. The quantity of solder balls or solder Splashes isn't beyond 5 in 600 mm ² .	Minor Major
		 c. Solder balls/Solder splashes do not violate minimum electrical clearance. d. Solder balls/Solder splashes must be entrapped/encapsulated Or attached to the metal surface . 	Minor
		NOTE: Entrapped/encapsulated/attached is intended to mean that normal service environment of the product will not cause a solder ball to become dislodged.	

4.2.2Cosmetic Criteria (Non-Operating)

No.	Defect	Judgment Criterion			
1	Spots	In accordance with Screen Cost	Minor		
2	Lines	In accordance with Screen Cost	netic Criteria (Operating) No.2.	Minor	
3	Bubbles in polarizer			Minor	
		Size : d mm	Acceptable Qty in active area		
		d ≤ 0.3	Disregard		
		$0.3 < d \le 1.0$	3		
		$1.0 < d \le 1.5$	1		
		1.5 < d	0		
4	Scratch	In accordance with spots and lines operating cosmetic criteria. When the			
		light reflects on the panel surface, the scratches are not to be remarkable.			
5	Allowable density	Above defects should be separated more than 30mm each other.			
6	Coloration	Not to be noticeable coloration in the viewing area of the LCD panels.			
		Back-lit type should be judged with back-lit on state only.			
7	Contamination	Not to be noticeable.		Minor	

4.2.3 Cosmetic Criteria (Operating)

No.	Defect		Judgment Cri	terion	Partition
1	Spots A) Clear				Minor
		Lcd size	Size : d mm	Acceptable Qty in active area	
			<u>d≤0.1</u>	Disregard	
		Lcd size≤8.0'	$0.1 < d \le 0.2$	6	
			$0.2 < d \le 0.3$	2	
			0.3 < d	0	
			d ≤0.1	Disregard	
		Lcd size>8.0'	0.1 <d≤0.3< td=""><td>10</td><td></td></d≤0.3<>	10	
			0.3 <d≤0.5< td=""><td>5</td><td></td></d≤0.5<>	5	
			0.5 < d	0	
		pixel size; Total d		re dots which must be within one all not exceed 6 pcs no more than an 8 inch LCD.	
		Lcd size	Size : d mm	Acceptable Qty in active area	
			d≤0.2	Disregard	
		Lcd size≤8.0'	0.2≤d≤0.5		
			0.5 <d≤0.7< td=""><td>2</td><td></td></d≤0.7<>	2	
			0.7 <d< td=""><td>0</td><td></td></d<>	0	
			d≤0.2	Disregard	
			0.2≤d≤0.5	10	
		Lcd size $>8.0'$	0.5 <d≤0.7< td=""><td>3</td><td></td></d≤0.7<>	3	
			0.7 <d≤1.0< td=""><td>1</td><td></td></d≤1.0<>	1	
			1.0< d	0	
		inch LCD and 10PCS f		exceed 6 pcs for no more than 8 ch LCD.	
2	Lines	A) Clear	- (0)		Minor
			(0)		
		2.0 (6)		——————————————————————————————————————	
		0.02	0.05 0.1	1 W	
		Note : () - Accepta L - Length (mm) W - Width (mm) ∞ - Disregard	ble Qty in active a	rea	
		B) Unclear			
			(6)	(0)	
		2.0		See No. 1	
		0.05	0.3	0.5 W	
			e and size are not cl		
		'Unclear' = The shade an			

3	Rubbing line	Not to be noticeable.	Minor
4	Allowable density	Above defects should be separated more than 10mm each other.	Minor
5	Rainbow	Not to be noticeable.	Minor
6	Dot size	To be 95% ~ 105% of the dot size (Typ.) in drawing. Partial defects of each dot (ex. pin-hole) should be treated as 'Spot'. (see <i>Screen Cosmetic Criteria (Operating) No.1</i>)	Minor
7	7 Uneven brightness (only back-lit type module) Uneven brightness must be BMAX / BMIN ≤ 2 - BMAX : Max. value by measure in 5 points - BMIN : Min. value by measure in 5 points Divide active area into 4 vertically and horizontally. Measure 5 points shown in the following figure. 0 0 0 0 0 0		Minor
		O : Measuring points	

Note :

(1) Size : d = (long length + short length) / 2

(2) The limit samples for each item have priority.

(3) Complex defects are defined item by item, but if the numbers of defects are defined in above table, the total number should not exceed 10.

(4) In case of 'concentration', even the spots or the lines of 'disregarded' size should not allowed. Following three situations should be treated as 'concentration'.

- 7 or over defects in circle of \emptyset 5mm.
- 10 or over defects in circle of \emptyset 10mm.
- 20 or over defects in circle of \emptyset 20mm.

■ PACKING SPECIFICATION

Please consult our technical department for detail information.